


<b>Search Notes</b>  	<b>Application/Control No.</b>  10682542	<b>Applicant(s)/Patent Under Reexamination</b>  WEE ET AL.
	<b>Examiner</b>  X. L Bautista	<b>Art Unit</b>  2179

SEARCHED			
Class	Subclass	Date	Examiner
715	700,716,717,719,753,764,771,773,863	08/28/08	XB
715	205	08/28/08	XB
345	156,173	8/28/08	XB
348	143,155,159	8/28/08	XB

SEARCH NOTES			
Search Notes		Date	Examiner
EAST Search		08/28/08	XB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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